



# Topographic contribution to non-linear rf losses: FG BCP cf. EP

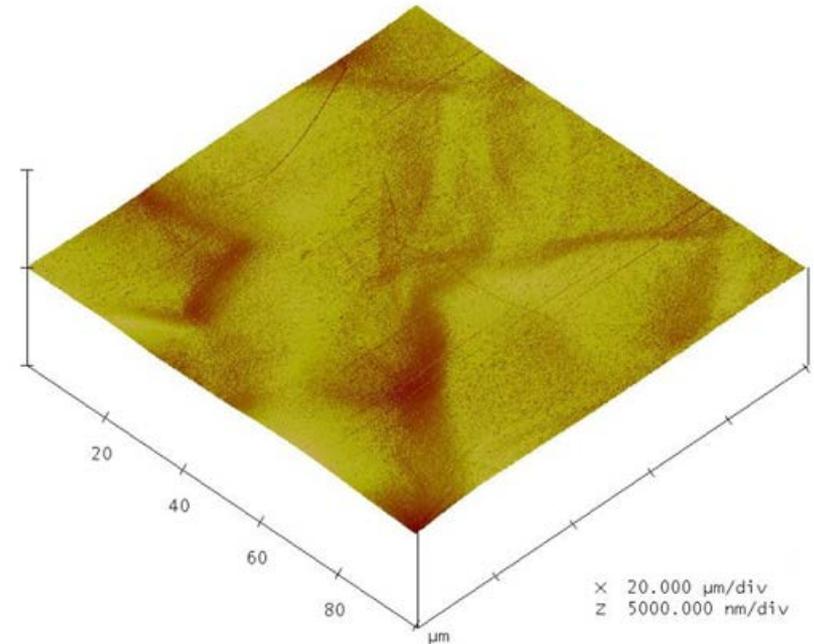
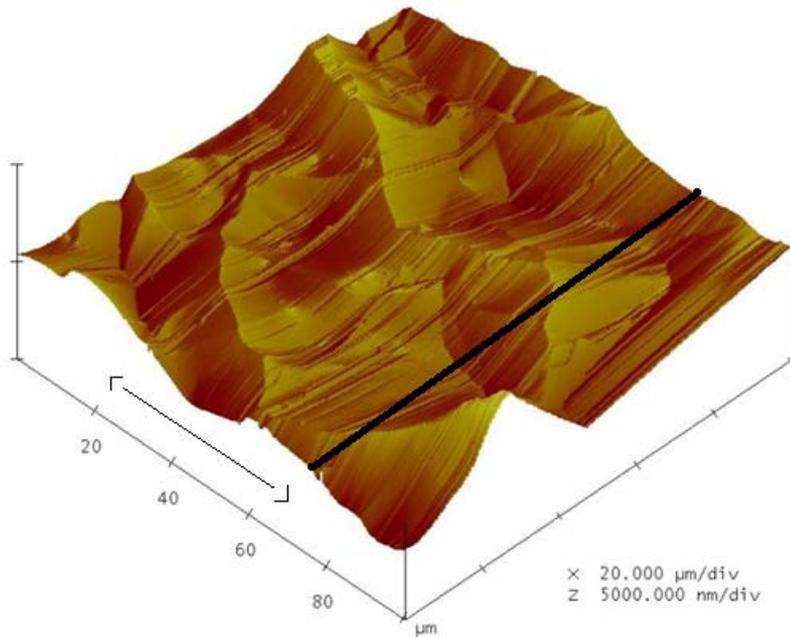
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# RF Loss Enhancement by Topography

- Local field enhancement at interior sharp edges yield “premature” performance limitations.
- Sharp corner in WG coupler limited LE5-cell cavity design – 1983
- Knobloch et al. suggested non-linear losses due to grain boundary enhancements.
- C. Antoine et al. began grain-edge field enhancement characterization at quench site in 2003.
- Microscopic roughness “looks bad”, but what really matters for cavity high-field performance?
- How much of the BCP vs EP high field performance difference is due simply to topography?
- **What roughness matters?**

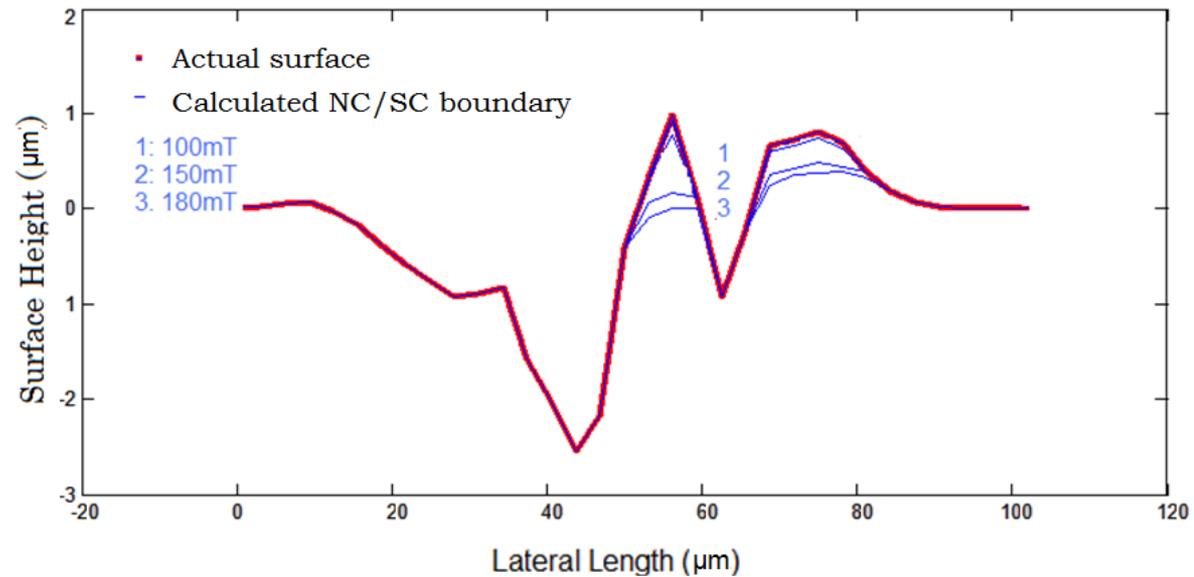
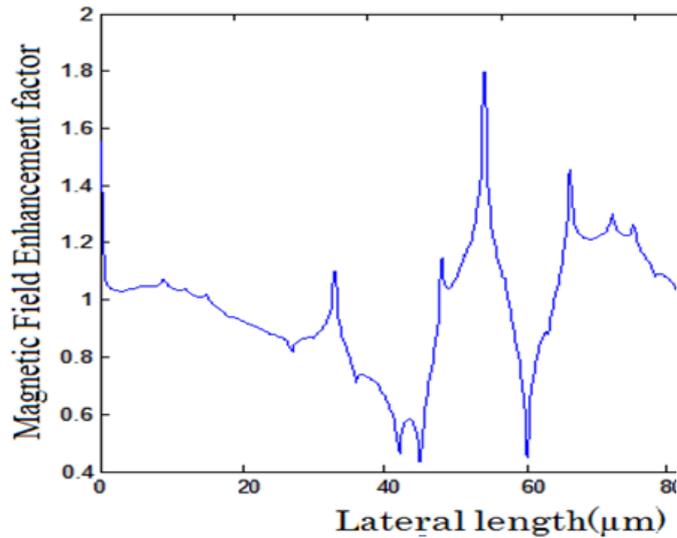
# BCP vs EP Topography



AFM images from a fine grain niobium sample with a)  $\sim 100\mu\text{m}$  removal by BCP, b) after EP to remove  $48\mu\text{m}$ . Horizontal scale is  $20\mu\text{m}$  per division and vertical scale is  $5\mu\text{m}$  per division.

PRST-AB 14, (2011) p.123501

# FG BCP Topography



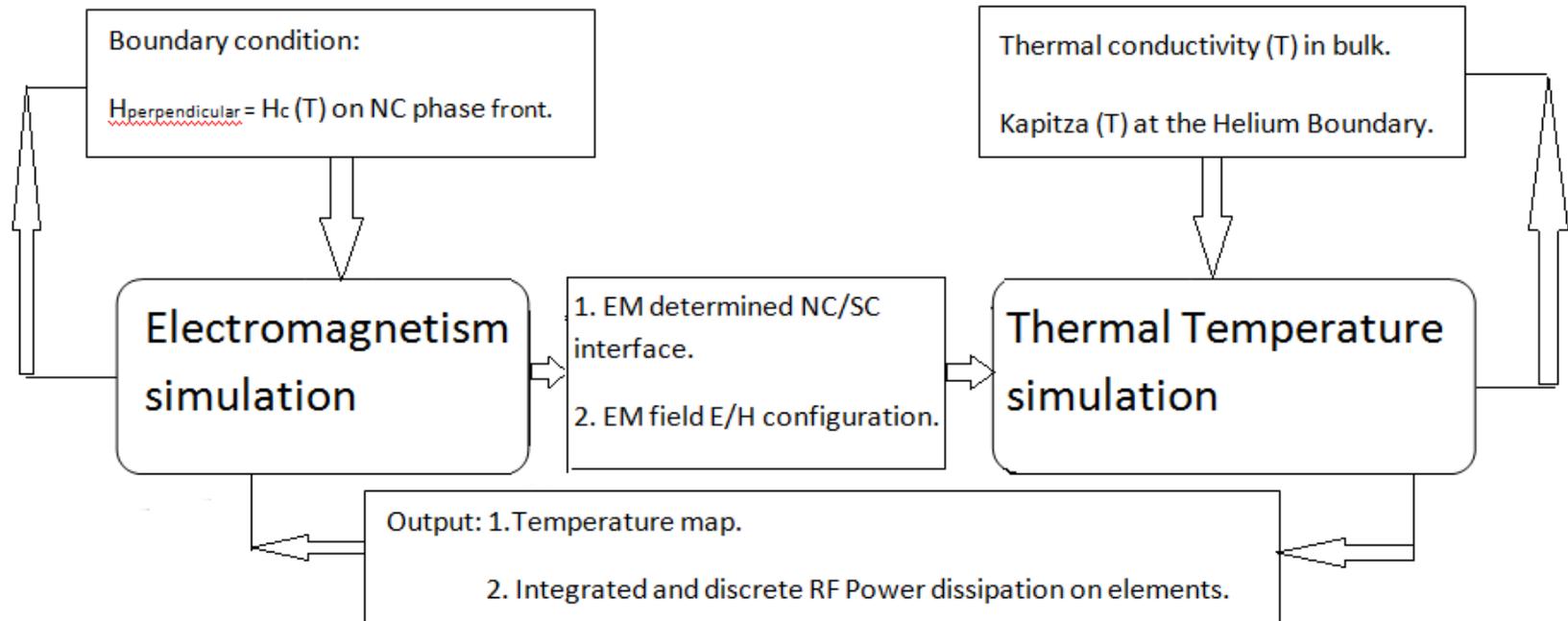
Treat the volume where  $H > H_c$  as normal material, but  $T < T_c$ .

Depth is less than normal skin depth.

Thermally stable because very small local volumes.

IPAC12 Chen Xu *et al.*  
SRF2013 Chen Xu *et al.*

# Simulation Structure

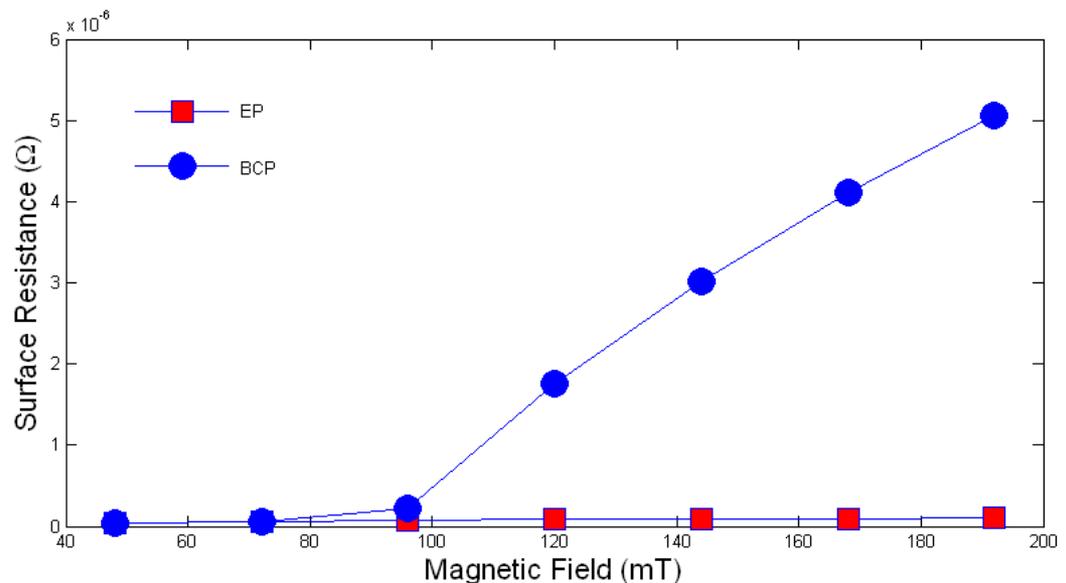
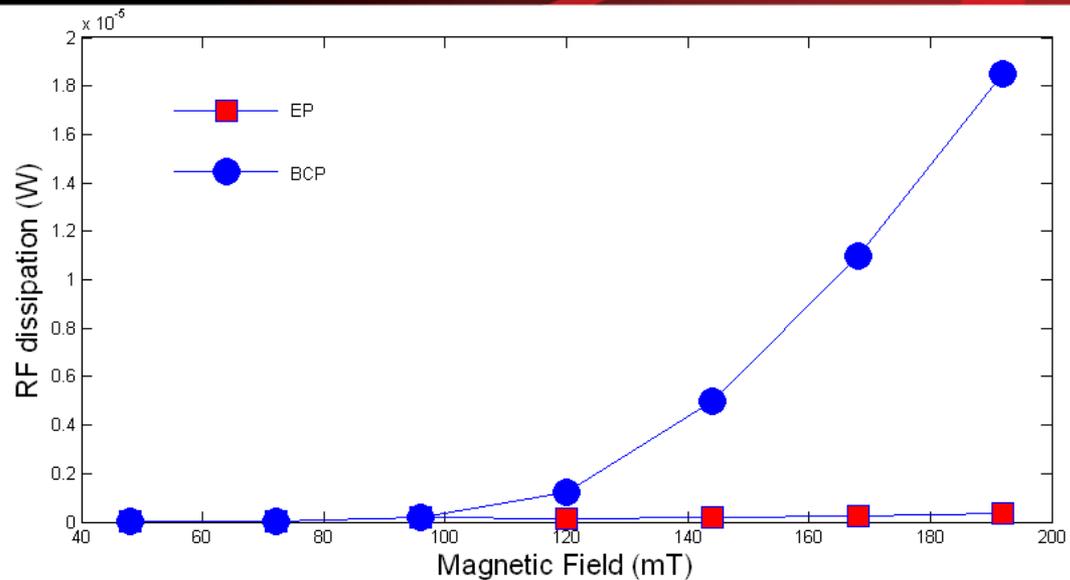


Flow chart of electromagnetic and temperature numerical simulations.

(Chen Xu PhD dissertation, W&M)

# Effective $R_s$ due to BCP and EP Topography

- Average the dissipated power over representative  $100 \times 100 \mu\text{m}$  surface
- Convert to effective surface resistance with applied  $H$
- Repeat with EP-derived topography
- Model neglects increased  $R_s$  of SC material with increasing  $T$



Chen Xu, to be published

# Effective $R_s$ due to BCP Topography

- Compare with BCP vs EP performance of a JLab cavity
- Analysis can be improved by using a finer mesh.
- In qualitative agreement with experimental experience.

